IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No.

: National Phase Entry of PCT/EP2004/011360

Applicant

: MASSELINK et al

Filed

: April 3, 2006

TC/A.U.

Examiner

Docket No. Customer No.: 6449

: 3367-102

Confirmation No.:

INFORMATION DISCLOSURE STATEMENT

Director of the United States Patent and Trademark Office P. O. Box 1450 Alexandria, VA 22313-1450

Sir:

In compliance with applicants duty of disclosure under 37 C.F.R. 1.56, enclosed is a copy of the International Search Report in the corresponding international application. References 1-2 and 12 — 14 are noted in the International Search Report and copies of the references are provided herewith for Examiner's review. Also enclosed is an English translation of an office action which issued in the priority German application. Reference No. 2 corresponds to Reference No. 12 listed in this IDS (see 1449).

Please charge any fee deficiency or credit any overpayment to Deposit Account No. 02-2135.

Respectfully submitted,

Robert B. Murray Attorney for Applicants

Registration No. 22,980

ROTHWELL, FIGG, ERNST & MANBECK, p.c.

Suite 800, 1425 K Street, N.W.

Washington, D.C. 20005 Telephone: (202)783-6040

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				Application Number	New Application	
	INFORMATION DISCLOSURE STATEMENT BY APPLICANT			Filing Date	April 3, 2006	
STATEM				First Named Inventor	MASSELINK et al	
				Group Art Unit		
				Examiner Name		
				Confirmation No.		
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U.S. PATENT DOCUMENTS							
Examiner	U.S. Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document		
Initials*	No.1	Number	Kind Code ² (if known)		MM-DD-YYYY		
·	1.	2002/0136932	A1	Yoshida	9/26/02		
	2.	2003/0170927	A1	Holonyak et al	9/11/03		
	3.	2002/0114367	A1	Stintz et al	8/22/02		
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			1973				
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¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code. ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.

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	INFORMATION DISCLOSURE STATEMENT BY APPLICANT				April 3, 2006		
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Sheet	2	of	3	Attorney Docket Number	3367-102		

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T²
	4.	W. T. Masselink and Yia-Chung Chang, "Theory of the Exciton Bound to an Isoelectronic Trap in GaP," Phys. Rev. Lett. 51, 509-512 (1983)	
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	9.	Goni et al, "Electronic Structure of self-assembled InP/GaP quantum dots from high-pressure photoluminescence", Physical Review, B, THE AMERICAN PHYSICAL SOCIETY, vol. 67 pgs. 075306-1- 075306-5, 2003.	
	10.	W. T. Masselink, F. Hatami, G. Mussler, and L. Schrottke: "InP quantum dots in (100) GaP: Growth and luminescence", <i>Materials Science in Semi-conductor Processing 4</i> , 497-501 (2001) (Proceedings of the International Conference on Materials for Advanced Technologies (ICMAT 2001), 1-6 July 2001, Singapore)	
	11.	F. Hatami, G. Mussler, M. Schmidbauer, L. Schrottke, HY. Hao, H. T. Grahn, and W. T. Masselink, "Optical emission from ultrathin strained type-II InP/GaP quantum wells", <i>Appl. Phys. Lett.</i> 79, 2886-8 (2001).	
	12.	Hatami et al., "Radiative recombination from InP quantum dots on (100) GaP", APPLIED PHYSICS LETTERS, vol. 78, no. 15, 9 April 2001, pgs. 2163-2165.	
	13.	Walter et al., "Room-temperature continuous photopumped laser operation of coupled InP quantum dot and InGaP quantum well InP-InGaP-In(AIGa)P-InAIP heterostructures", APPLIED PHYSICS LETTERS, vol. 79, no. 13, 24 September 2001, pgs. 1956-1958.	
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		of	3	Attorney Docket Number	3367-102	

Examiner Signature		Date Considered	
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